Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/509,074	CHEN ET AL.	
Examiner	Art Unit	
Sahiha Oazi	1616	

	SEARCHED		
Class	Subclass	Date	Examiner
548	453	9/27/2006	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEAR)
	DATE	EXMR
STN DATABASE SEARCH	9/27/2006	STIC
REGISTRY		
STRUCTURE		
HCAPLUS		
INVENTOR SEARCH		